

# Search Notes



Application/Control No.

09/813,636

Examiner

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Applicant(s)/Patent under Reexamination

BORTON, GREGORY F.

Art Unit

3629

## SEARCHED

Class	Subclass	Date	Examiner
205	1	7/30/05	DN
	7	↓	↓
	8	↓	↓
	9	↓	↓
	10	↓	↓

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
I US	7/30/05	DN
Patent Pg Rub	↓	↓
II FOREIGN		
1. EPO	↓	↓
2. JPO		
3. Derwent		
4. IBM-TDB	↓	↓